

FORM PTO-1449 (Modified)

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S  
INFORMATION  
DISCLOSURE STATEMENT

(Use several sheets if necessary)

ATTY. DOCKET NO.

FI9-96-085

SERIAL NO.

APPLICANT:

ROY FLAKER (DECEASED), ET AL.

FILING DATE:

GROUP:

 JCS 35 U.S. PTO  
 09/588351  
 06/07/00

## REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

EXAMINER INITIALS		DOCUMENT NUMBER	ISSUED DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPRO.)
<i>MS</i>	AA	4,946,799	8/7/90	Blake, et al.	437	41	11/9/89
	AB	5,420,055	5/30/95	Vu, et al	437	40	11/16/93
	AC	4,006,458	2/1/77	Booher	340	147 R	2/9/76
	AD	5,448,513	9/5/95	Hu, et al.	365	150	12/2/93
	AE	5,498,882	3/12/96	Houston	257	57	1/20/95
	AF	4,169,233	9/23/79	Haraszti	307	355	2/24/78
	AG	4,253,162	2/24/81	Hollingsworth	365	175	8/28/79
<i>AM</i>	AH	5,426,605	6/20/95	Berkel, et al.	365	182	8/18/93
	AI	4,700,086	10/13/87	Ling, et al.	307	443	4/23/85

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
	<del>AJ</del>						
	AK					X	
	AL					X	
						X	

## OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

AN	E. DUBOIS, ET AL., ANOMALOUS VOLTAGE OVERSHOOT DURING TURN-OFF OF THIN-FILM n-CHANNEL SOI MOSFET's, IEEE ELECTRON DEVICE LETTERS, VOL. 14, NO. 4, APRIL 1993,
AO	JACQUES GAUTIER, ET AL. ON THE TRANSIENT OPERATION OF PARTIALLY DEPLETED SOI NMOSFET's, IEEE ELECTRON DEVICE LETTERS, VOL. 16, NO 11, NOV. 1995,
AP	DONGWOOK SUH, ET AL. PHYSICAL MODELING OF BENEFICIAL DYNAMIC FLOATING-BODY EFFECTS IN NON-FULLY DEPLETED SOI CMOS CIRCUITS, PROCEEDINGS 1994 IEEE INTERNATIONAL SOI CONFERENCE, OCT. 1994,

EXAMINER

*John G. Serty*

DATE CONSIDERED

*1/17/07*

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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EXAMINER INITIALS		DOCUMENT NUMBER	ISSUED DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPRO.)
	AA	4,494,015	1/15/85	FRIELING, ET AL.	307	268	2/8/92
	AB	4,513,431	4/23/85	CHAMBERLAIN, ET AL.	377	60	6/7/82
	AC	3,990,056	11/2/76	LUISI, ET AL.	340	173	10/2/75
	AD	3,916,169	10/28/75	COCHRAN, ET AL.	235	156	9/13/73
	AE	5,489,792	2/6/96	HU, ET AL.	257	347	4/7/94
	AF	5,145,802	9/8/92	TYSON, ET AL.	437	63	11/12/91
	AG	5,293,052	3/8/94	CHERNE, ET AL.	257	349	3/23/92
	AH	5,405,795	4/11/95	BEYER, ET AL.	437	41	6/29/94
	AI	5,045,916	9/3/91	VOR, ET AL.	357	71	7/19/89

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AJ							
	AK						X	
	AL						X	
							X	

## OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

AN	DONGWOOK SUH, ET AL., DYNAMIC FLOATING-BODY INSTABILITIES IN PARTIALLY DEPLETED SOI CMOS CIRCUITS, 1994 IEEE, PGS. 27.6.1-27.6.4.
AO	J. G. FOSSUM, ET AL., FLOATING-BODY PROBLEMS AND BENEFIS IN FULLY DEPLETED SOI CMOS VLSI CIRCUITS, 1991 IEEE, PGS. 12.1.1-12.1.4.
AP	MAKOTO YOSHIMI, ET AL., TECHNOLOGY TRENDS OF SILICON-ON-INSULATOR - ITS ADVANTAGES AND PROBLEMS TO BE SOLVED - , 1994 IEEE, PGS. 17.1.1-17.1.4.

EXAMINER

*John L. Smith*

DATE CONSIDERED

*11/17/88*

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## U.S. PATENT DOCUMENTS

EXAMINER INITIALS		DOCUMENT NUMBER	ISSUED DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPRO.)
<i>[Signature]</i>	AA	5,317,181	5/31/94	TYSON, ET AL.	257	347	9/10/92
	AB	H1435	5/2/95	CHERNE, ET AL.	257	347	10/21/91
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

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							YES	NO
	AJ							
	AK						X	
	AL						X	
							X	

## OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

AN	JACQUES GAUTIER, ET AL., BODY CHARGE RELATED TRANSIENT EFFECTS IN FLOATING BODY SOI NMOSFET's, 1995 IEEE, PGS. 26.1.1 - 26.1.4.
AO	DONGWOOK SUH, ET AL., A PHYSICAL CHARGE-BASED MODEL FOR NON-FULLY DEPLETED SOI MOSFET's AND ITS USE IN ASSESSING FLOATING-BODY EFFECTS IN SOI CMOS CIRCUITS, APRIL 1995 IEEE TRANSACTIONS ON ELECTRON DEVICES, VOL. 42, NO 4.
AP	

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11/17/97

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# INFORMATION DISCLOSURE STATEMENT

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Docket Number (Optional)  
FI9-96-085

Application Number

Applicant(s)

Roy Flaker (deceased), et al.

Filing Date  
4/22/98

Group Art Unit

PTO S. N. 58821

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		5,689,127	11/18/97	CHU, ET AL.	257	329	3/5/96
		5,729,039	3/17/98	BEYER, ET AL.	257	347	5/3/96
		5,736,891	4/7/98	BUTI, ET AL.	327	434	1/11/96
		5,753,525	5/19/98	HSU, ET AL.	437	43	12/19/95
		5,759,907	6/2/98	ASSADERAGHI, ET AL.	438	386	3/21/97
		5,675,164	10/7/97	BRUNNER, ET AL.	257	331	6/7/95
		5,663,578	9/2/97	HSU, ET AL.	257	66	8/2/96
		5,643,813	7/1/97	ACOCCELLA, ET AL.	437	43	5/4/95
		5,633,522	5/27/97	DORLEANS, ET AL.	257	344	5/14/96
		5,622,881	4/22/97	ACOCCELLA, ET AL.	438	264	10/6/94
		5,599,725	2/4/97	DORLEANS, ET AL.	437	40	11/22/94

## FOREIGN PATENT DOCUMENTS

REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)


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DATE CONSIDERED

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**Expire Date**

**U.S. PATENT DOCUMENTS**

FOREIGN PATENT DOCUMENTS

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**EXAMINER**

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EXAMINER: *[Signature]*

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